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Team Nexperia

PHK04P02T

P-channel vertical D-MOS logic level FET Rev. 02 — 14 December 2010

Product data sheet

Product profile 1.

1.1 General description

Logic level P-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using vertical D-MOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Suitable for high frequency applications due to fast switching characteristics
- Suitable for logic level gate drive sources
- Suitable for very low gate drive sources voltage

1.3 Applications

- Battery powered applications
- High-speed digital interfaces

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}$	-	-	-16	V
I _D	drain current	T _{sp} = 25 °C	-	-	-4.6 6	Α
P _{tot}	total power dissipation			-	5	W
Static cha	aracteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = -2.5 \text{ V}; I_D = -1 \text{ A}; T_j = 25 \text{ °C}$	-	117	150	mΩ
		$V_{GS} = -4.5 \text{ V}; I_D = -1 \text{ A}; T_j = 25 \text{ °C}$	-	80	120	mΩ
Dynamic	characteristics					
Q_{GD}	gate-drain charge	$V_{GS} = -4.5 \text{ V}; I_D = -1 \text{ A};$ $V_{DS} = -10 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	1.83	-	nC



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source	8 <u>Д Д Д Д</u> 5	D
3	S	source		
4	G	gate		G L L
5	D	drain	1 1 1 1 14	
6	D	drain	SOT96-1 (SO8)	S 001aaa025
7	D	drain		
8	D	drain		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PHK04P02T	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-16	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	-16	V
V_{GS}	gate-source voltage		-8	8	V
I _D	drain current	T _{sp} = 100 °C	-	-1.87	Α
		T _{sp} = 25 °C	-	-4.66	Α
I _{DM}	peak drain current	$T_{sp} = 25 ^{\circ}C; pulsed$	-	-26.4	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C	-	5	W
		T _{sp} = 100 °C	-	2	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-dra	in diode				
Is	source current	T _{sp} = 25 °C	-	-4.66	Α
I _{SM}	peak source current	$T_{sp} = 25 \text{ °C}$; pulsed; $t_p \le 5 \text{ s}$	-	-26	Α

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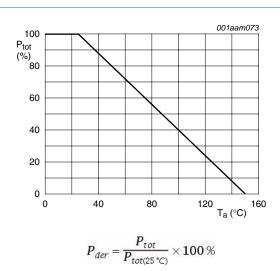
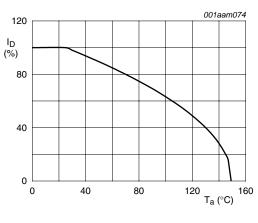


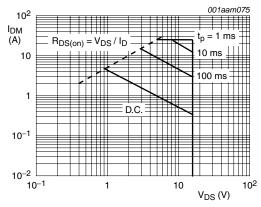
Fig 1. Normalised power dissipation as a function of ambient temperature



$$I_{\rm der} = \frac{I_{\rm D}}{I_{\rm D(25^{\circ}C)}} \times 100\,\%$$

V_{GS} ≤ -10 V

Fig 2. Normalized continuous drain current as a function of ambient temperature



 T_{sp} = 25 °C; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

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5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	mounted on metal clad substrate	-	25	-	K/W

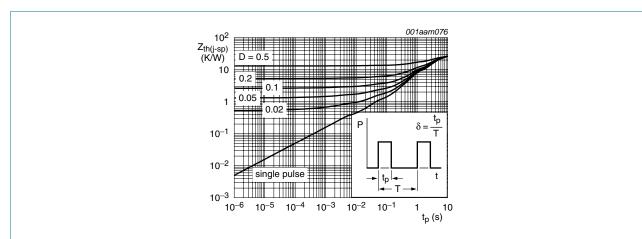


Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration

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6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = -10 \mu A; V_{GS} = 0 V; T_j = 25 °C$	-16	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = -1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	-0.4	-0.6	-	V
		$I_D = -1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ °C}$	-0.1	-	-	V
I _{DSS}	drain leakage current	$V_{DS} = -13 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-50	-100	nΑ
		$V_{DS} = -13 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 ^{\circ}\text{C}$	-	-13	-100	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nΑ
		$V_{GS} = -8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nΑ
R_{DSon}	drain-source on-state	V_{GS} = -2.5 V; I_{D} = -1 A; T_{j} = 25 °C	-	117	150	mΩ
	resistance	V_{GS} = -2.5 V; I_D = -1 A; T_j = 150 °C	-	175	230	mΩ
		V_{GS} = -1.8 V; I_D = -0.5 A; T_j = 25 °C	-	140	180	mΩ
		V_{GS} = -4.5 V; I_{D} = -1 A; T_{j} = 25 °C	-	80	120	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = -1 A$; $V_{DS} = -10 V$; $V_{GS} = -4.5 V$;	-	7.2	-	nC
Q_{GS}	gate-source charge	T _j = 25 °C	-	1.7	-	nC
Q_{GD}	gate-drain charge		-	1.83	-	nC
C _{iss}	input capacitance	$V_{DS} = -13 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	528	-	pF
C _{oss}	output capacitance	T _j = 25 °C	-	200	-	pF
C _{rss}	reverse transfer capacitance		-	57	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = -10 \text{ V}; R_L = 10 \Omega; V_{GS} = -8 \text{ V};$	-	2	-	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C; I_D = -1 A$	-	4.5	-	ns
t _{d(off)}	turn-off delay time		-	45	-	ns
t _f	fall time		-	20	-	ns
9 fs	transfer conductance	$V_{DS} = -13 \text{ V}; I_{D} = -1 \text{ A}; T_{j} = 25 \text{ °C}$	1.5	4.5	-	S
Source-d	rain diode					
V_{SD}	source-drain voltage	$I_S = -0.62 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-0.62	-1.3	V
t _{rr}	reverse recovery time	$I_S = -0.5 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	75	-	ns
Q _r	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = -12.8 \text{ V}; T_j = 25 \text{ °C}$	-	69	-	nC

Product data sheet

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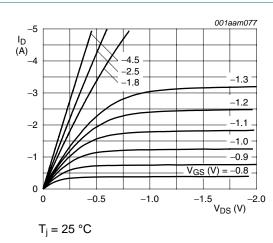


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

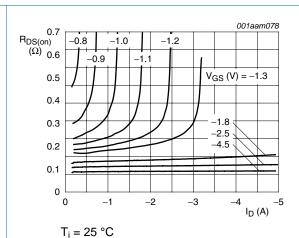


Fig 6. Drain-source on-state resistance as a function of drain current; typical values

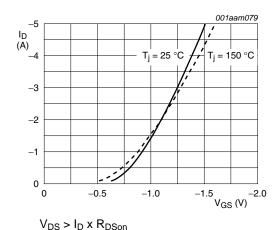


Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

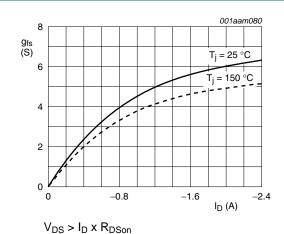


Fig 8. Forward transconductance as a function of drain current; typical values

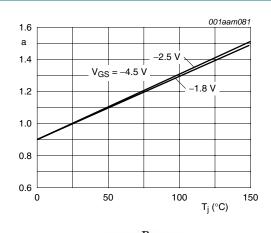


Fig 9. Normalized drain-source on-state resistance factor as a function of junction temperature

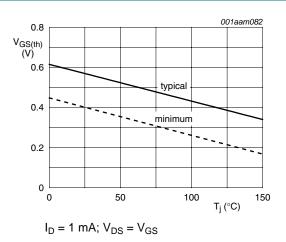


Fig 10. Gate-source threshold voltage as a function of junction temperature

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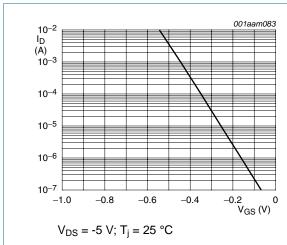
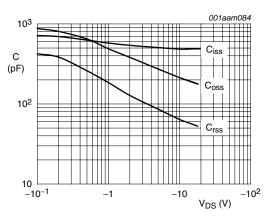


Fig 11. Sub-threshold drain current as a function of gate-source voltage



 $V_{GS} = 0 V; f = 1 MHz$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

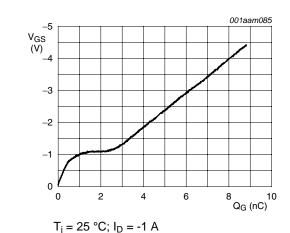
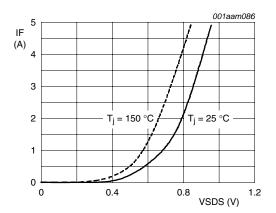


Fig 13. Gate-source voltage as a function of turn-on gate charge; typical values



 $V_{GS} = 0 V$

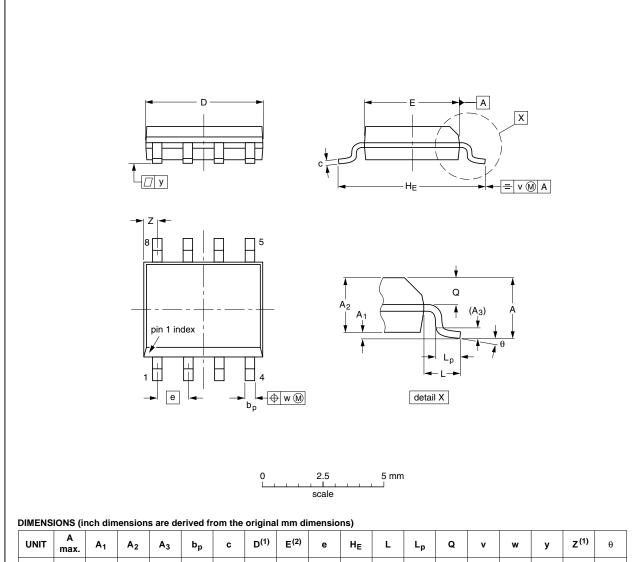
Fig 14. Reverse diode current as a function of reverse diode voltage; typical values

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7. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.20 0.19	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

			REFERENCES						
IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE				
076E03	MS-012				99-12-27 03-02-18				

Fig 15. Package outline SOT96-1 (SO8)

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
PHK04P02T v.2	20101214	Product data sheet	-	PHK04P02T v.1				
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 							
 Legal texts have been adapted to the new company name where appropriate. 								
PHK04P02T v.1	20020501	Product specification	-	-				

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9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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